HIGH POWER SWITCHING USE INSULATED TYPE

CM900DUC-24NF

- MPD series using 5th Generation IGBT and FWDi

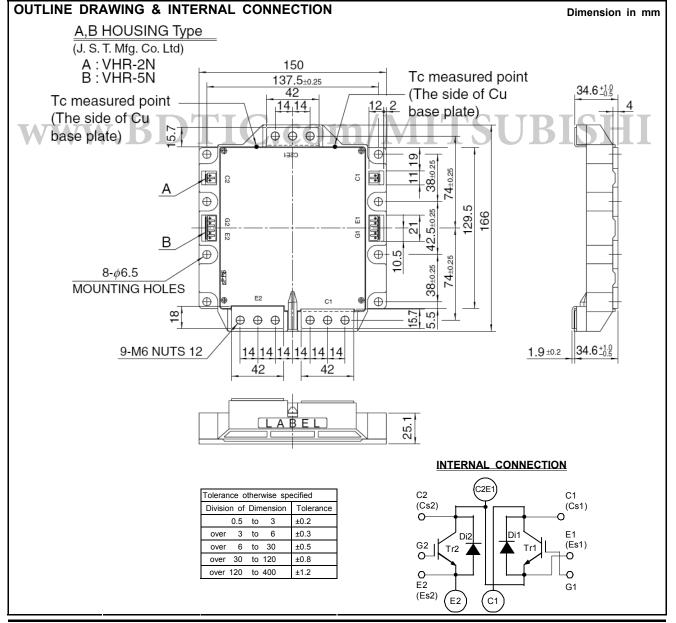


- •Flat base Type
- •Copper (non-plating) base plate
- •RoHS Directive compliant

•UL Recognized under UL1557, File E323585

APPLICATION

AC Motor Control, Motion/Servo Control, Power supply, etc.



HIGH POWER SWITCHING USE INSULATED TYPE

ABSOLUTE MAXIMUM RATINGS (T_j=25 °C, unless otherwise specified)

Symbol	Item	Conditions	Rating	Unit
V _{CES}	Collector-emitter voltage	G-E short-circuited	1200	V
V_{GES}	Gate-emitter voltage	C-E short-circuited	± 20	V
Ic	Collector current	DC, T _C =96 °C (Note2)	900	Α
I _{CRM}	- Collector current	Pulse, Repetitive (Note3)	1800	_ ^
P _{tot}	Total power dissipation	T _C =25 °C (Note2, 4)	5950	W
I _E (Note1)	Emitter current	T _C =25 °C (Note2, 4)	900	^
I _{ERM} (Note1)	(Free wheeling diode forward current)	Pulse, Repetitive (Note3)	1800	Α
V _{isol}	Isolation voltage	Terminals to base plate, RMS, f=60 Hz, AC 1 min	2500	V
Tj	Junction temperature	-	-40 ~ +150	°C
T _{stg}	Storage temperature	(Note7)	-40 ~ +125	

ELECTRICAL CHARACTERISTICS (T_j=25 °C, unless otherwise specified)

Cumbal	Itom	Conditions		Limits			Unit
Symbol	Item			Min.	Тур.	Max.	Unit
I _{CES}	Collector-emitter cut-off current	V _{CE} =V _{CES} , G-E short-circuited		-	-	1	mA
I _{GES}	Gate-emitter leakage current	V _{GE} =V _{GES} , C-E short-circuited		-	-	1	μΑ
V _{GE(th)}	Gate-emitter threshold voltage	I _C =90 mA, V _{CE} =10 V		6	7	8	V
V _{CEsat}		I _C =900 A (Note5),	T _j =25 °C	-	1.8	2.5	V
V CEsat	Collector-emitter saturation voltage	V _{GE} =15 V	T _j =125 °C	-	2.0	-	V
Cies	Input capacitance			-	-	140	nF
Coes	Output capacitance	V _{CE} =10 V, G-E short-circu	ited	-	-	16	
C_{res}	Reverse transfer capacitance			-	-	3.0	
Q_{G}	Gate charge	V _{CC} =600 V, I _C =900 A, V _{GE} =15 V		-	4800	-	nC
$t_{d(on)}$	Turn-on delay time	V _{CC} =600 V, I _C =900 A, V _{GE} =±15 V,). 	ļ.	600	
tr	Rise time			GI	IRI	200	ne
t _{d(off)}	Turn-off delay time	R_G =0.35 Ω , Inductive load	ATTT		ועו	800	ns
t _f	Fall time			-	-	300	
V _{EC} (Note1)	Emitter-collector voltage	I _E =900 A, G-E short-circuited (Note5)		-	2.5	3.2	V
t _{rr} (Note1)	Reverse recovery time	V _{CC} =600 V, I _E =900 A, V _{GE} =±15 V,		-	-	500	ns
Q _{rr} (Note1)	Reverse recovery charge	R_G =0.35 Ω , Inductive load		-	50	-	μC
Eon	Turn-on switching energy per pulse	V _{CC} =600 V, I _C =I _E =900 A,		-	147.5	-	
E _{off}	Turn-off switching energy per pulse	V_{GE} =±15 V, R_{G} =0.35 Ω ,	T _j =125 °C,	-	88	-	mJ
E _{rr} (Note1)	Reverse recovery energy per pulse	Inductive load		-	91.8	-	
R _{CC'+EE'}	Internal lead resistance	Main terminals-chip, per s T_C =25 °C $^{(Note2)}$	witch,	-	0.286	-	mΩ
r_g	Internal gate resistance	Per switch		-	1.0	-	Ω

THERMAL RESISTANCE CHARACTERISTICS

Symbol	Item	Conditions	Limits			Unit
			Min.	Тур.	Max.	Oill
$R_{th(j-c)Q}$	Thermal resistance (Note2)	Junction to case, per IGBT	-	-	21	K/kW
$R_{th(j-c)D}$		Junction to case, per FWDi	-	-	34	K/kW
R _{th(c-s)}	Contact thermal resistance (Note2)	Case to heat sink, per 1/2 module, Thermal grease applied (Note6)	-	12	-	K/kW

MECHANICAL CHARACTERISTICS

Symbol Item	Itom	Conditions	Limits			Unit
	Conditions	Min.	Тур.	Max.	Offic	
Mt	Mounting torque	Main terminals M 6 screw	3.5	4.0	4.5	N·m
Ms		Mounting to heat sink M 6 screw	3.5	4.0	4.5	INTIII
m	Weight	-	-	1450	-	g
e _c	Flatness of base plate	On the centerline X, Y1, Y2 (Note8)	-50	-	+100	μm



April-2012

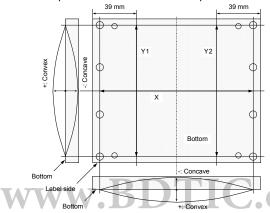
HIGH POWER SWITCHING USE INSULATED TYPE

RECOMMENDED OPERATING CONDITIONS

Symbol	Item	Conditions	Limits			Unit
			Min.	Тур.	Max.	Offic
Vcc	(DC) Supply voltage	Applied across C1-E2	-	600	800	V
V_{GEon}	Gate (-emitter drive) voltage	Applied across G1-Es1/G2-Es2	13.5	15.0	16.5	v
R _G	External gate resistance	Per switch	0.35	-	2.2	Ω

- Note1. Represent ratings and characteristics of the anti-parallel, emitter-collector free wheeling diode (FWDi).
 - 2. Case temperature (T_c) and heat sink temperature (T_s) are defined on the each surface of base plate and heat sink just under the chips. (Refer to the figure of chip location)

 The heat sink thermal resistance $\{R_{th(s-a)}\}$ should measure just under the chips.
 - 3. Pulse width and repetition rate should be such that the device junction temperature (T_j) dose not exceed T_{jmax} rating.
 - 4. Junction temperature (T_i) should not increase beyond T_{imax} rating.
 - 5. Pulse width and repetition rate should be such as to cause negligible temperature rise. (Refer to the figure of test circuit)
 - 6. Typical value is measured by using thermally conductive grease of λ =0.9 W/(m·K).
 - 7. The operation temperature is restrained by the permission temperature of female connector housing.
 - 8. Base plate flatness measurement points are as in the following figure.



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9. Generally, the company name, the brand name listed in this material are the trademark of the companies or registered tradem arks



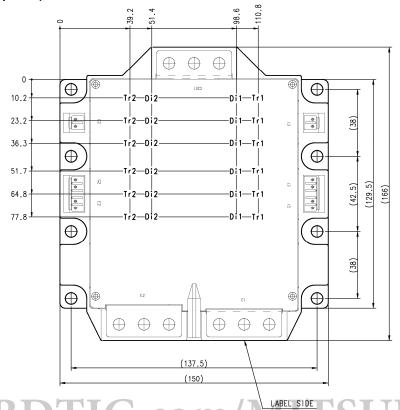
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MITSUBISHI IGBT MODULES CM900DUC-24NF

HIGH POWER SWITCHING USE INSULATED TYPE

CHIP LOCATION (Top view)

Dimension in mm, tolerance: ±1 mm

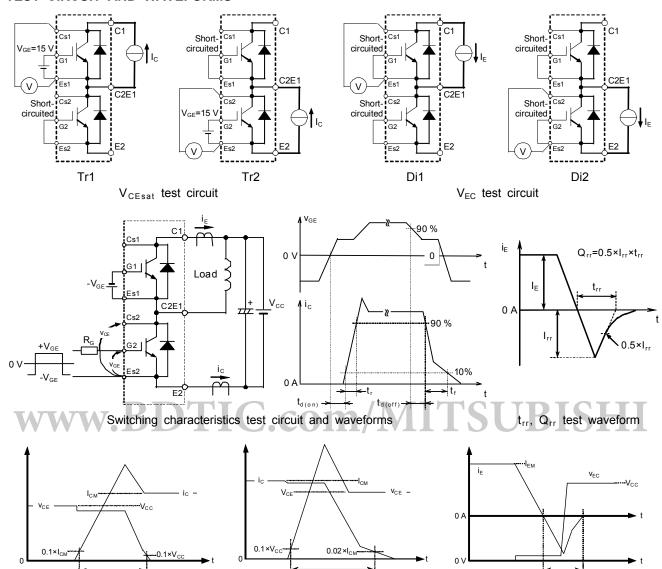


Tr1/Tr2: IGBT, Di1/Di2: FWDi. Each mark points the center position of each chip.



HIGH POWER SWITCHING USE INSULATED TYPE

TEST CIRCUIT AND WAVEFORMS



E_{on}
IGBT Turn-on switching energy

 E_{off} IGBT Turn-off switching energy

FWDi Reverse recovery energy

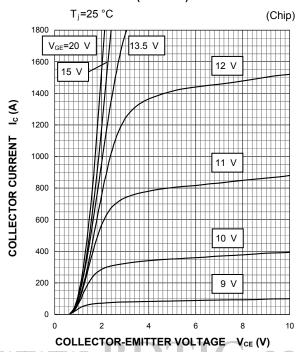
Err

Turn-on / Turn-off switching energy and Reverse recovery energy integral range

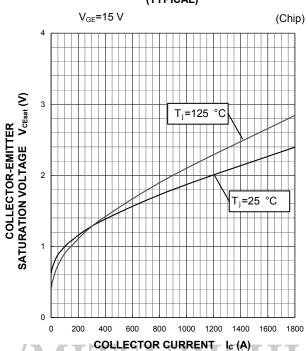
HIGH POWER SWITCHING USE INSULATED TYPE

PERFORMANCE CURVES

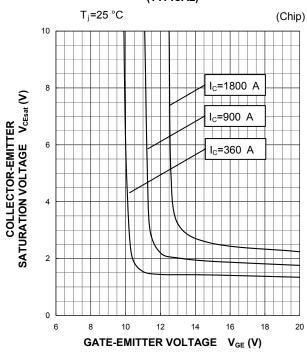
OUTPUT CHARACTERISTICS (TYPICAL)



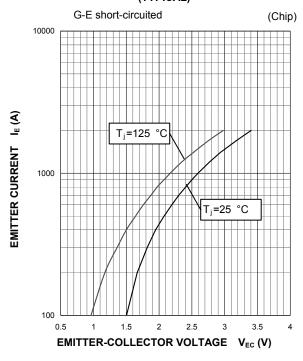
COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS (TYPICAL)



COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS (TYPICAL)



FREE WHEELING DIODE FORWARD CHARACTERISTICS (TYPICAL)

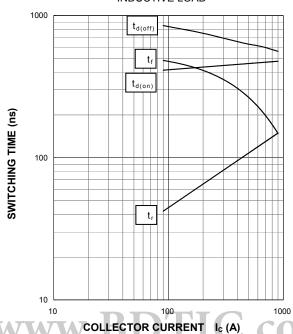




HIGH POWER SWITCHING USE **INSULATED TYPE**

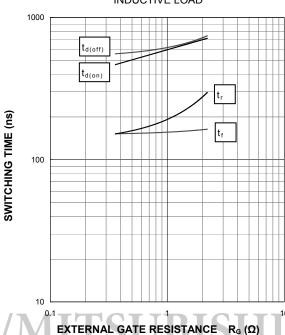
HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

 $V_{CC}=600 \text{ V}, V_{GE}=\pm 15 \text{ V}, R_G=0.35 \Omega, T_i=125 ^{\circ}\text{C},$ INDUCTIVE LOAD



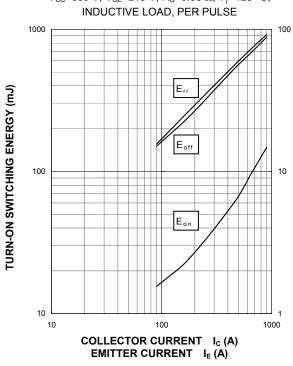
HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

 V_{CC} =600 V, I_{C} =900 A, V_{GE} =±15 V, T_{i} =125 °C, INDUCTIVE LOAD



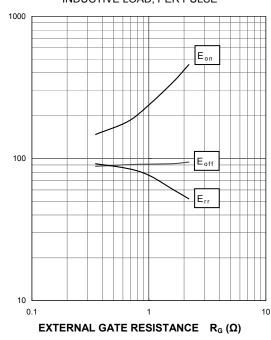
HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

 $V_{CC}=600 \text{ V}, V_{GE}=\pm 15 \text{ V}, R_G=0.35 \Omega, T_i=125 ^{\circ}\text{C},$



HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

 V_{CC} =600 V, I_C/I_E =900 A, V_{GE} =±15 V, T_i =125 °C, INDUCTIVE LOAD, PER PULSE

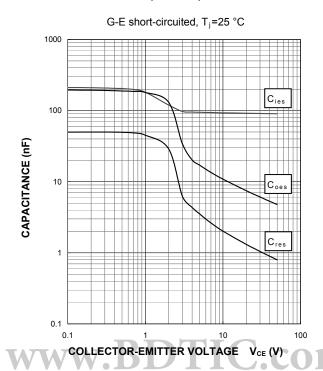


TURN-OFF SWITCHING ENERGY (mJ) REVERSE RECOVERY ENERGY (mJ)

SWITCHING ENERGY (mJ)
REVERSE RECOVERY ENERGY (mJ)

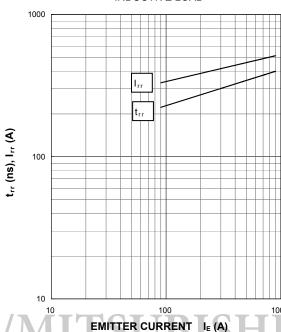
HIGH POWER SWITCHING USE **INSULATED TYPE**

CAPACITANCE CHARACTERISTICS (TYPICAL)

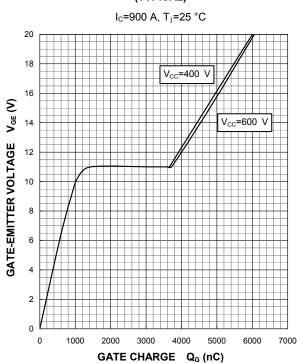


FREE WHEELING DIODE REVERSE RECOVERY CHARACTERISTICS (TYPICAL)

 V_{CC} =600 V, V_{GE} =±15 V, R_G =0.35 Ω , T_j =25 °C, INDUCTIVE LOAD

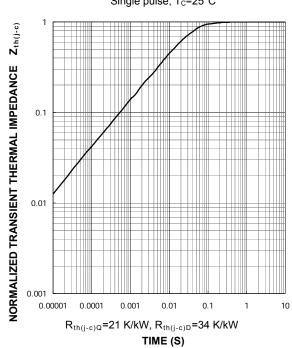


GATE CHARGE CHARACTERISTICS (TYPICAL)



TRANSIENT THERMAL IMPEDANCE **CHARACTERISTICS** (MAXIMUM)

Single pulse, T_C=25°C



INSULATED TYPE

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